TEXAS INSTRUMENTS

TS3DV642-Q1 8 Gbps 12-Channel differential 1-to-2 and 2-to-1 mux

1 Features

- Automotive Q100 qualified
- Temperature range of -40 to 105 °C (grade 2)
- Support 6 differential or 12 single-ended signals or other differential/single ended combinations
- Supports HDMI 1.4b / 2.0, DisplayPort 1.4 HBR3, Mipi DPHY / CPHY DSI / CSI-2
- Bidirectional analog mux - handles most electrical signals within 0 to 5 V and DC to 8.1 Gbps range
- –3-dB differential BW of 6.5 GHz
- Excellent dynamic characteristics
  - Insertion loss: –1.5 dB at 3.0 GHz
  - Return loss: –14 dB at 3.0 GHz
- Support 1.8 V, 3.3 V or 5.0 V control logic
- Single supply voltage of 3.3 V
- Low active (45 µA) and standby power (6 µA)
- I_{OFF} protection that prevents current leakage when supply rail collapsed (V_{CC} = 0 V)
- ESD Performance of 2 kV HBM and 1 kV CDM
- 42-pin, 3.5 x 9 mm, 0.5 mm pitch WQFN package with wettable flank

2 Applications

- Advanced driver assistance systems (ADAS)
- Automotive infotainment & cluster
- Rear seat entertainment
- Automotive head unit
- Aerospace & defense

3 Description

The TS3DV642-Q1 is an analog high-speed bidirectional passive switch in mux or demux configurations that works for many high-speed differential interfaces with data rates up to 8.1 Gbps. It is suited for many applications including HDMI 1.4 / 2.0, DisplayPort 1.4 and Mipi DPHY/CPHY DSI / CSI-2. The TS3DV642-Q1 supports both differential and single-ended signaling - virtually compatible to most standard and non standard interfaces. The dynamic characteristics of the TS3DV642-Q1 allows high-speed switching with minimal attenuation to the signal eye diagram, and with very little added jitter. The device's silicon design is optimized for excellent frequency response at higher frequency spectrum of the signals. The device supports differential signaling with common mode voltage range (CMV) of 0 to 3.6 V and 0 - 5.5 V CMOS signals.

The TS3DV642-Q1 consumes very low active power of 45 µA. The device also offers a power-down mode, in which all channels become Hi-Z and the device operates with minimal power.

Device Information [(1)]

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TS3DV642-Q1	WQFN (42)	3.50 mm x 9.00 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

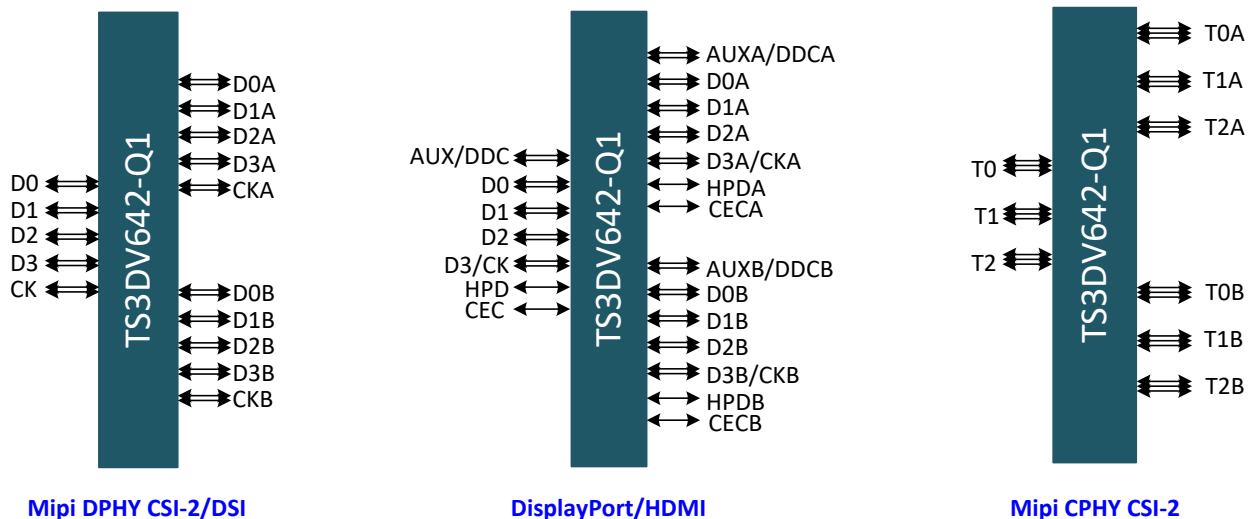**ADVANCE INFORMATION**

Simplified Use Cases

Mipi DPHY CSI-2/DSI

DisplayPort/HDMI

Mipi CPHY CSI-2

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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Date	Revision	Notes
December 2020	*	Initial Release

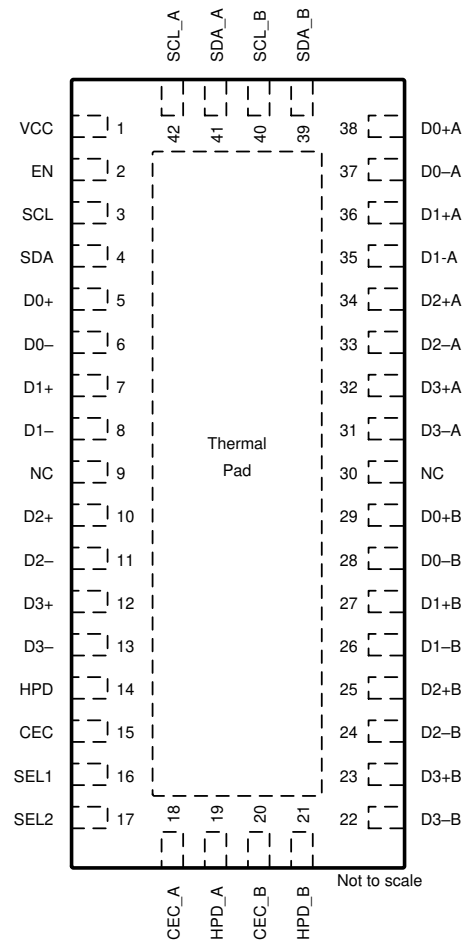Product Folder Links: *TS3DV642-Q1*

5 Pin Configuration and Functions

Figure 5-1. 42 Pin WQFN RUA Package with exposed thermal pad - top view - not to scale

Pin Functions

PIN		TYPE	DESCRIPTION
NAME	NO.		
VCC	1	Power	Supply Voltage
SEL1	16	I	Select Input 1
SEL2	17	I	Select Input 2
EN	2	I	Device Enable
D0+A	38	I/O	Port A, Channel 0, +ve signal
D0–A	37	I/O	Port A, Channel 0, –ve signal
D1+A	36	I/O	Port A, Channel 1, +ve signal
D1-A	35	I/O	Port A, Channel 1, –ve signal
D2+A	34	I/O	Port A, Channel 2, +ve signal
D2–A	33	I/O	Port A, Channel 2,–ve signal
D3+A	32	I/O	Port A, Channel 3, +ve signal
D3–A	31	I/O	Port A, Channel 3, –ve signal
SCL_A	42	I/O	Port A, DDC Clock
SDA_A	41	I/O	Port A, DDC Data
HPD_A	19	I/O	Port A, Hot Plug Detects

Product Folder Links: *TS3DV642-Q1*

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PIN		TYPE	DESCRIPTION
NAME	NO.		
CEC_A	18	I/O	Port A, Consumer Electronics Control
D0+B	29	I/O	Port B, Channel 0, +ve signal
D0–B	28	I/O	Port B, Channel 0, –ve signal
D1+B	27	I/O	Port B, Channel 1, +ve signal
D1–B	26	I/O	Port B, Channel 1, –ve signal
D2+B	25	I/O	Port B, Channel 2, +ve signal
D2–B	24	I/O	Port B, Channel 2,–ve signal
D3+B	23	I/O	Port B, Channel 3, +ve signal
D3–B	22	I/O	Port B, Channel 3, –ve signal
SCL_B	40	I/O	Port B, DDC Clock
SDA_B	39	I/O	Port B, DDC Data
HPD_B	21	I/O	Port B, Hot Plug Detects
CEC_B	20	I/O	Port B, Consumer Electronics Control
D0+	5	I/O	Common Port, Channel 0, +ve signal
D0–	6	I/O	Common Port, Channel 0, –ve signal
D1+	7	I/O	Common Port, Channel 1, +ve signal
D1–	8	I/O	Common Port, Channel 1, –ve signal
D2+	10	I/O	Common Port, Channel 2, +ve signal
D2–	11	I/O	Common Port, Channel 2, –ve signal
D3+	12	I/O	Common Port, Channel 3, +ve signal
D3–	13	I/O	Common Port, Channel 3,–ve signal
SCL	3	I/O	Common Port, DDC Clock
SDA	4	I/O	Common Port, DDC Data
HPD	14	I/O	Common Port, Hot Plug Detects
CEC	15	I/O	Common Port, Consumer Electronics Control
NC	9, 30	NC	No Connect
GND	PowerPad	GND	Ground

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)[1]

			MIN	MAX	UNIT
$VCC_{ABS MAX}$	Supply voltage range		−0.5	5.5	V
$V_{I/O-ABSMAX}$	Analog voltage range[2] [3] [4]	All I/O (data pins)	−0.5	5.5	V
$V_{IN-ABSMAX}$	Digital input voltage range[2] [3]	SEL1, SEL2, EN	−0.5	5.5	V
T_{jmax}	Maximum junction temperature		−40	125	°C
T_{stg}	Storage temperature range		−65	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. Theseare stress ratings only, which do not imply functional operation of the device at these or anyother conditions beyond those indicated under *Recommended OperatingConditions*. Exposure to absolute-maximum-rated conditions for extended periods mayaffect device reliability.
(2) All voltages are with respect to ground, unless otherwisespecified.
(3) The input and output voltage ratings may be exceeded if theinput and output clamp-current ratings are observed.
(4) V_I and V_O areused to denote specific conditions for $V_{I/O}$.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, [1]	±2000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, [2]	±1000	

(1) JEDEC document JEP155 states that 500-V HBM allows safemanufacturing with a standard ESD control process.
(2) JEDEC document JEP157 states that 250-V CDM allows safemanufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)[1]

		MIN	MAX	UNIT
VCC	Supply voltage	3.0	3.6	V
$V_{I/O,CM}$	Input/Output common mode voltage (data pins)	0	3.6	V
$V_{I/O}$	Input/Output voltage (data pins)	0	5.5	V
V_{IN}	Digital input voltage (control pins)	0	5.5	V
DR	Data rate for differential signals		8.1	Gbps
T_A	Operating ambient temperature	−40	105	°C
T_J	Operating junction temperature	−40	110	°C

(1) All unused control inputs of the device must be held at VDD orGND to ensure proper device operation. Refer to the *TI application report,Implications of Slow or Floating CMOS Inputs,* literature numberSCBA004.

6.4 Thermal Information

	THERMAL METRIC[1]	TS3DV642-Q1	UNIT
		RUA	
		42 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	28.7	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	16.7	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	9.7	°C/W
ψ_{JT}	Junction-to-top characterization parameter	0.3	°C/W

THERMAL METRIC[1]		TS3DV642-Q1	UNIT
		RUA	
		42 PINS	
Ψ_{JB}	Junction-to-board characterization parameter	9.7	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	2.9	°C/W

(1) For more information about traditional and new thermalmetrics, see the Semiconductor and ICPackage Thermal Metrics application report.

6.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER			TEST CONDITIONS[1]	MIN	TYP[2]	MAX	UNIT
DC Characteristics							
R_{ON}	ON-state resistance	All data pins	$V_{I/O}$ = 0 V, $I_{I/O}$ = –10 mA		7	12	Ω
$R_{ON,FLAT}$ [3]	ON-state resistance flatness	All data pins	R_{ON} at $V_{I/O}$ = 1.5 V minus R_{ON} at $V_{I/O}$ = 0 V, $I_{I/O}$ = –10 mA			0.6	Ω
I_{OFF}	Leakage under power off (failsafe current)	All data and control pins	VCC = 0 V, $V_{I/O}$ or V_{IN} = 0 V to 5.5 V			±10	μA
Control Inputs (SEL1, SEL2, EN)							
V_{IH}	High-level input voltage for control pins	SEL1, SEL2, EN		1.4			V
V_{IL}	Low-level input voltage for control pins	SEL1, SEL2, EN				0.5	V
I_{IH}	Input high leakage current for control pins	SEL1, SEL2, EN	VCC = 3.6 V, V_{IN} = 5.5 V			±10	μA
I_{IL}	Input low leakage current for control pins	SEL1, SEL2, EN	VCC = 3.6 V, V_{IN} = GND			±10	μA
Power Supply							
I_{CC}	VCC supply current in active mode		EN = H		45		μA
I_{CC_PD}	VCC supply current in power-down mode		EN = L		6		μA

(1) V_I, V_O, I_I, and I_O refer to data I/O pins, V_{IN} refers to the control inputs.
(2) All typical values are at V_{DD} = 3.3 V (unless otherwise noted), T_A = 25°C.
(3) $R_{ON,FLAT}$ is the difference of R_{ON} in a given channel at specified voltages.

6.6 High-Speed Performances

Over recommended operation free-air temperature range, V_{DD} =3.3V ± 0.3V (unless otherwise noted). For all data pins. R_L = 50 Ω where applicable.

PARAMETER		TEST CONDITIONS	MIN	TYP[1]	MAX	UNIT
BW	Differential Bandwidth (–3 dB from DC)			6.5		GHz
IL	Differential insertion loss	DC		–0.6		dB
		1.7 GHz		–0.9		dB
		2.7 GHz		–1.3		dB
		3.0 GHz		-1.5		dB
		4.05 GHz		–1.9		dB
RL_{DAB}	Differential return loss for Port A and B (DA, DB)	DC		–24		dB
		1.7 Ghz		–22		dB
		2.7Ghz		–16		dB
		3.0 Ghz		–14		dB
		4.05 Ghz		–11		dB

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Over recommended operation free-air temperature range, V_{DD} =3.3V ± 0.3V (unless otherwise noted). For all data pins. R_L = 50 Ω where applicable.

PARAMETER		TEST CONDITIONS	MIN	TYP[1]	MAX	UNIT
Xtalk	Differential crosstalk	DC		-80		dB
		1.7 GHz		−40		dB
		2.7 GHz		−30		
		3.0 GHz		−27	-	
		4.05 GHz		−22		
OISO	Differential off isolation	DC		−80		dB
		1.7 GHz		−21		
		2.7 GHz		−16		
		3.0 GHz		−16		
		4.05 GHz		−15		

(1)   All Typical Values are at V_{DD} = 3.3 V(unless otherwise noted), T_A = 25°C.

6.7 Switching Characteristics

over recommended operation free-air temperature range, V_{DD} =3.3 V± 0.3 V (unless otherwise noted).   For all data pins.

PARAMETER		TEST CONDITIONS	MIN	TYP[1]	MAX	UNIT
t_{pd}	Propagation Delay	All I/O		66		ps
t_{ON} [2]	Switch turn-on time	All I/O			100	µs
t_{SWITCH} [3]	Switching time between channels	All I/O		20		µs

(1)   All typical values are at V_{DD} = 3.3 V(unless otherwise noted), T_A = 25°C.
(2) t_{ON} is the time it takes the output to recover within 95% of final value after enabling switches
(3) t_{SWITCH} is the time it takes for theoutput to recover within 95% of final value after the state is changed

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6.8 Typical Characteristics

Figure 6-1 shows typical s-parameter plots for TS3DV642-Q1 - top differential forward gain (S21/S12) and bottom differential return loss (S11/S22) in TI evaluation board with measurement parasitics calibrated out.
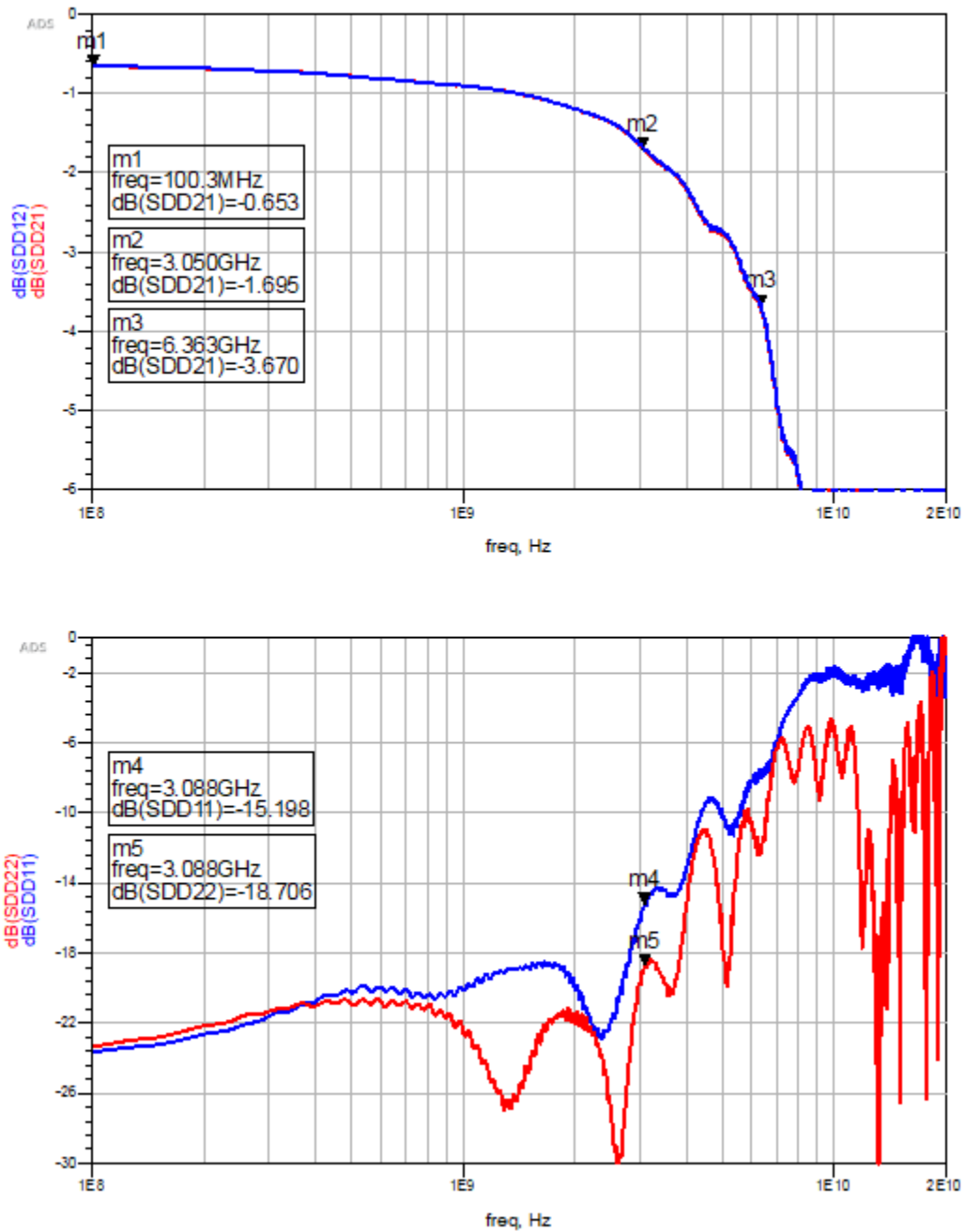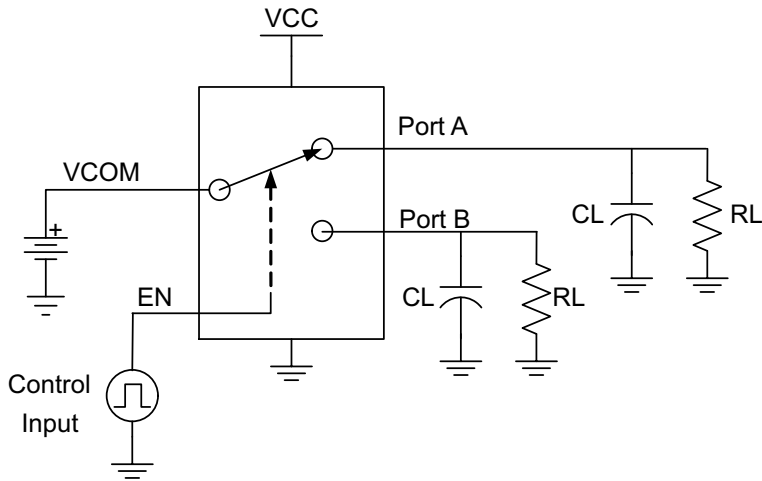

Figure 6-1. Differential gain (S21/S12) and return loss (S11/S22) vs frequency of TS3DV642-Q1

ADVANCE INFORMATION

Product Folder Links: *TS3DV642-Q1*

7 Parameter Measurement Information

RL	CL	VCOM
50 Ω	4 pF	Vcc

*CL includes probe, cable, and board capacitance
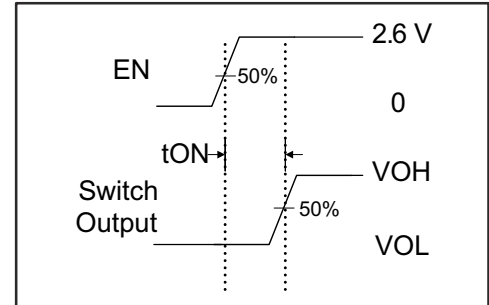
Figure 7-1. Switch Turn-On Time (t_ON)
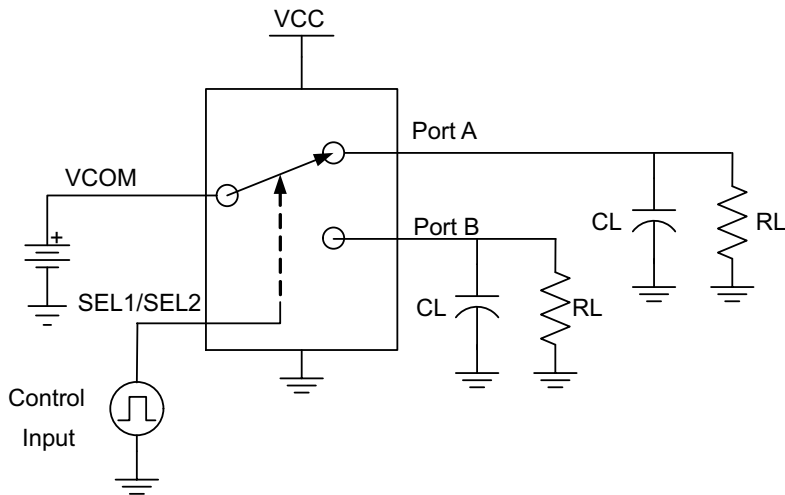
RL	CL	VCOM
50 Ω	4 pF	Vcc

*CL includes probe, cable, and board capacitance
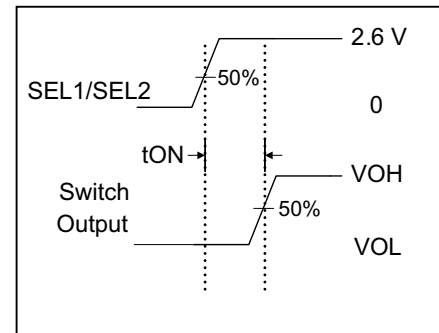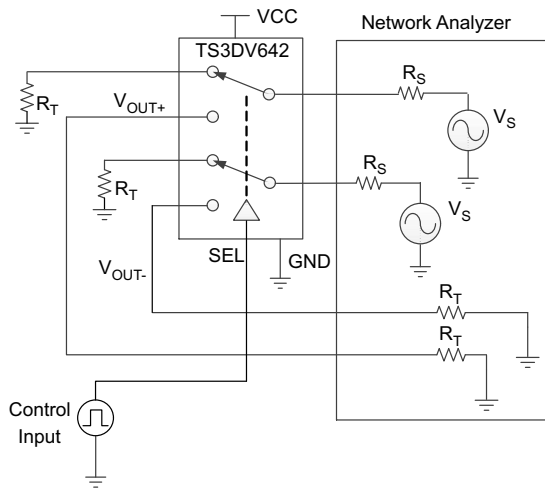
Figure 7-2. Switching Time Between Channels (t_SWITCH)
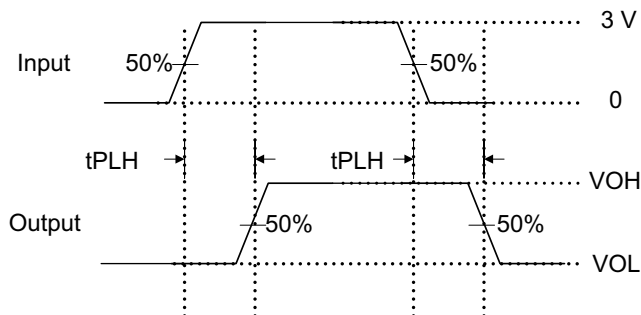
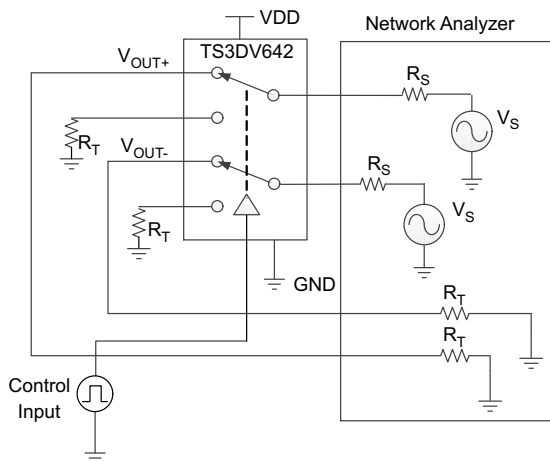$$tpd = (tPLH + tPLH) / 2$$

Figure 7-3. Propagation Delay (t_pd)

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ADVANCE INFORMATION
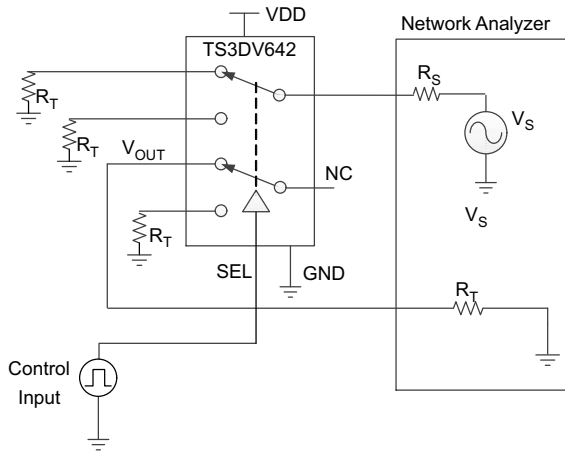
Figure 7-4. Crosstalk (Xtalk)

Channel ON

SEL = H or L
$R_S = R_T = 50Ω$

V_S = -10dBm (200mV at 50Ω Load)
V_{DC_BIAS} = 1 V

Figure 7-5. Differential Off-Isolation (OISO)

Channel OFF

SEL = H or L
$R_S = R_T = 50Ω$

V_S = -10dBm (200mV at 50Ω Load)
V_{DC_BIAS} = 1 V

Figure 7-6. Differential Bandwidth (BW)

Channel ON

SEL = H or L
$R_S = R_T = 50Ω$

V_S = -10dBm (200mV at 50Ω Load)
V_{DC_BIAS} = 1 V

Product Folder Links: *TS3DV642-Q1*

8 Detailed Description

8.1 Overview

The TS3DV642-Q1 is a 6 differential channel or 12 single ended channel bidirectional multiplexer/demultiplexer. It offers low on-state resistance as well as low I/O capacitance which allows it to achieve a high bandwidth. The TS3DV642-Q1 is a passive mux that is recommended for data rates up to 8.1 Gbps, however the device can be used for interfaces with higher data rates if overall electrical link loss permits. The device provides the high bandwidth necessary for many interfaces to handle differential and as well as single ended signals. The device supports differential signaling with common mode voltage range (CMV) of 0 to 3.6 V and 0 - 5.5 V CMOS signals.

The TS3DV642-Q1 has total 6 differential channels. All these channels are functionaly equivalent and provides almost identical electrical performance. The channels can be used in an arbitrary fashion for differential and single ended signals in any order.

8.2 Functional Block Diagram
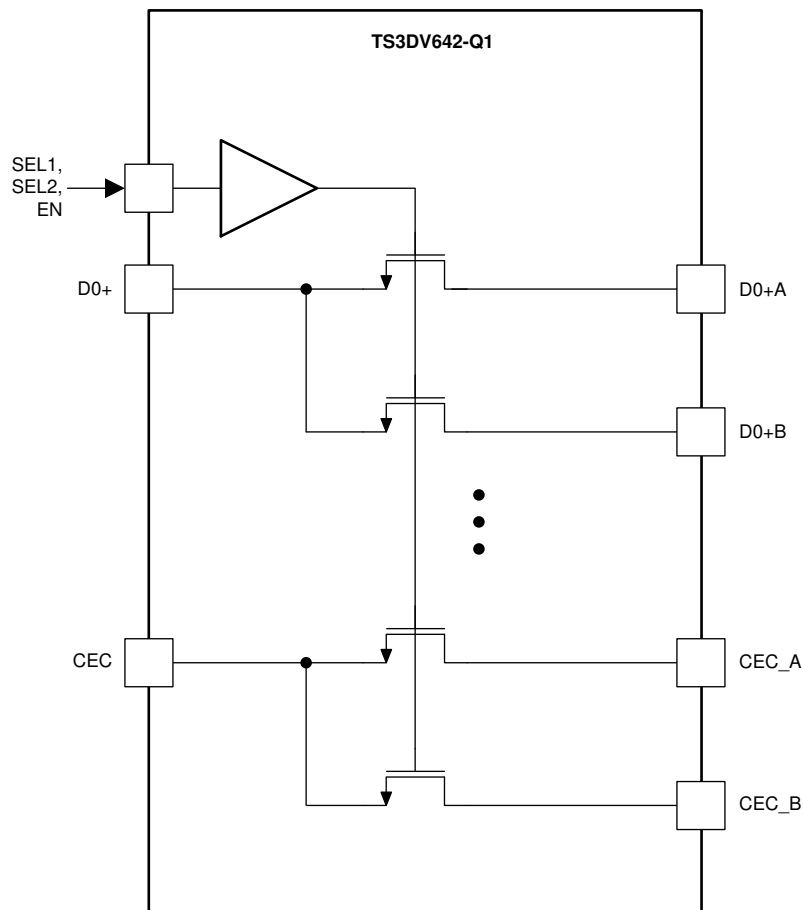
8.3 Feature Description

The TS3DV642-Q1 is based on proprietary TI technology which uses FET switches driven by a high-voltage generated from an integrated charge-pump to achieve a low on-state resistance. TS3DV642-Q1 has 6 differential channel or 12 single ended channel bidirectional switches with a high bandwidth. TS3DV642-Q1 uses an extremely low power technology and uses only 45 µA I_{CC} in active mode. The device has integrated ESD that can support up to 2-kV Human-Body Model (HBM) and 1-kV Charge Device Model (CDM). TS3DV642-Q1 is offered in a 42-pin QFN package (9 mm x 3.5 mm) with 0.5 mm pitch. The device can support analog I/O signal in 0 to 5.5 V range. TS3DV642-Q1 also has a special feature that prevents the device from back-powering when the V_{CC} supply is not available and an analog signal is applied on the I/O pin. In this situation this special feature

prevents leakage current in the device. The TS3DV642-Q1 is not designed for passing signals with negative swings.
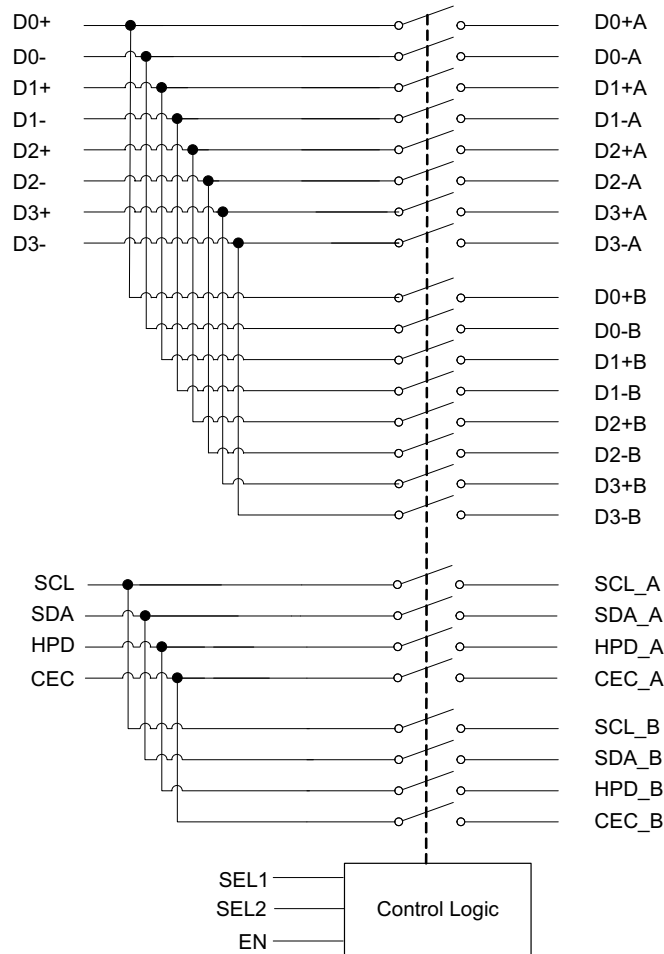
8.4 Device Functional Modes

Figure 8-1. Logic Diagram

Table 8-1 lists the device functions for the TS3DV642-Q1 device.

Table 8-1. Functional Table

EN	SEL1	SEL2	FUNCTION
L	X	X	Switch disabled. All channels are Hi-Z.
H	L	L	Channel D0+/D0– to D0+A/D0–A is ON. All the other channels (D1+/D1-, D2+/D2-, D3+/D3-, SCL, SDA, HPD, CEC) are Hi-Z.
H	L	H	Channel D0+/D0– to D0+B/D0–B is ON. All the other channels (D1+/D1-, D2+/D2-, D3+/D3-, SCL, SDA, HPD, CEC) are Hi-Z.
H	H	L	All A channels are enabled. All B channels are Hi-Z.
H	H	H	All B channels are enabled. All A channels are Hi-Z.

Product Folder Links: *TS3DV642-Q1*

ADVANCE INFORMATION

9 Application and Implementation

> **Note**
>
> Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The TS3DV642-Q1 is an analog differential passive mux or demux that works for many high-speed differential interfaces with data rates up to 8.1 Gbps. The device also works for single ended signals. The TS3DV642-Q1 supports differential signaling with common mode voltage range (CMV) of 0 to 3.6 V and with differential amplitude up to 1800 mVpp, and single ended CMOS signaling with swing limited to 0 to 5.5 V. TS3DV642-Q1 can be used as mux or demux switch for:

* HDMI 1.4 and HDMI 2.0 - up to 6 Gbps per channel
* DisplayPort (DP) for RBR, HBR, and HBR-3 data rates - up to 8.1 Gbps per lane
* Mipi DPHY interfaces such as DSI and CSI-2 - up to 4.5 Gbps per lane
* Mipi CPHY based CSI-2
* LVDS

6 Channels of the TS3DV642-Q1 are functionaly equivalent and can be used in an arbitrary fashion for differential and single ended signals in any order. For example in Mipi DPHY applications any of the 6 differential channels can be used for clock signals. For Mipi CPHY applications the data pins can be grouped any order to form trio signals. For HDMI application, while TS3DV642-Q1 data signal pins are marked for specific HDMI use, the main-link data, main-link clock, DDC, HPD, CEC can be assigned in any order if required.

9.2 Typical Application - Switching HDMI Source

The TS3DV642-Q1 can be used to switch HDMI signals. Figure 9-1 shows use case where TS3DV642-Q1 switches HDMI signals either from an external connector or from an SOC. This is a multiplexing use case. The device can also be used as a demultiplexer where a graphics processor can be switched into one of the two HDMI connectors. This section provides detailed design implemenation for a HDMI application where TS3DV642-Q1 provides 2:1 multiplexing function.
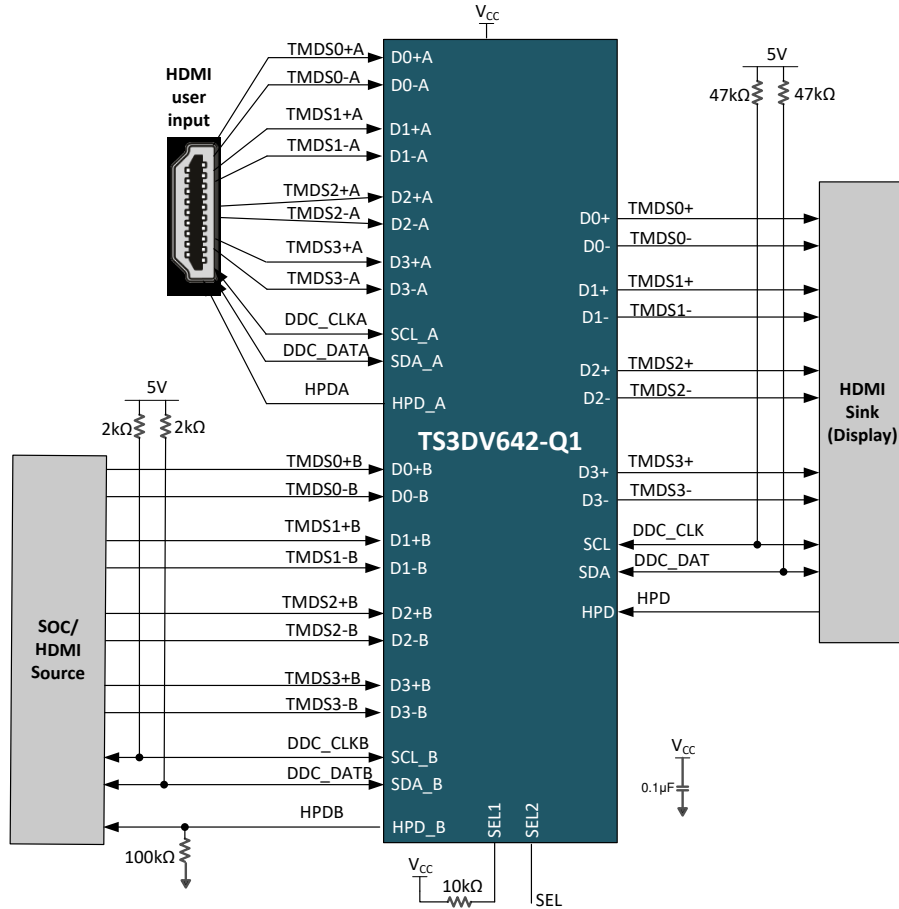
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Figure 9-1. Switching HDMI application schematic

9.2.1 Design Requirements

Table 9-1. Design Parameters for HDMI Application

Design parameter	Example value
V_{CC}	3.0 V to 3.6 V
VCC decoupling capacitor	0.1 µF
DDC Pull-up resistors on sink side	47 kΩ to 5 V
DDC Pull-up resistors on source side	2 kΩ to 5 V
HPD pulldown resistor on source side	100 kΩ to GND
Pull-up / Pull-down resistors for SEL1 / SEL2 pins	10 kΩ

9.2.2 Detailed Design Procedure

The TS3DV642-Q1 is designed to operate with 3.0 V to 3.6 V power supply. Decoupling capacitors may be used to reduce noise and improve power supply integrity. Pull-up resistors to 5 V must be placed on the sinke side DDC clock and data lines according to the HDMI standard.

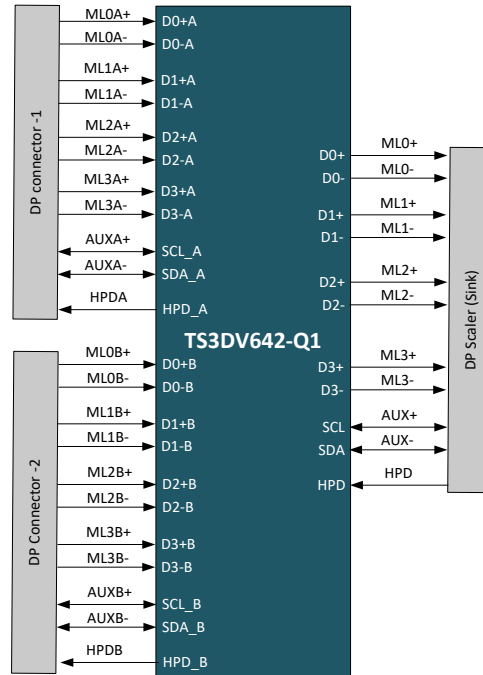**9.2.3 Systems Examples**

9.2.3.1 DisplayPort 2:1 mulitplexing

Figure 9-2. DisplayPort 2:1 switching
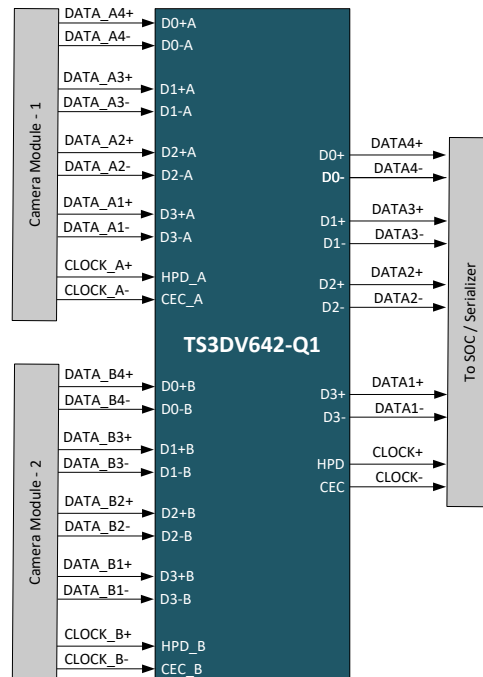
9.2.3.2 Mipi DPHY based CSI-2 switching

Figure 9-3. Mipi DPHY based CSI-2 switching

ADVANCE INFORMATION

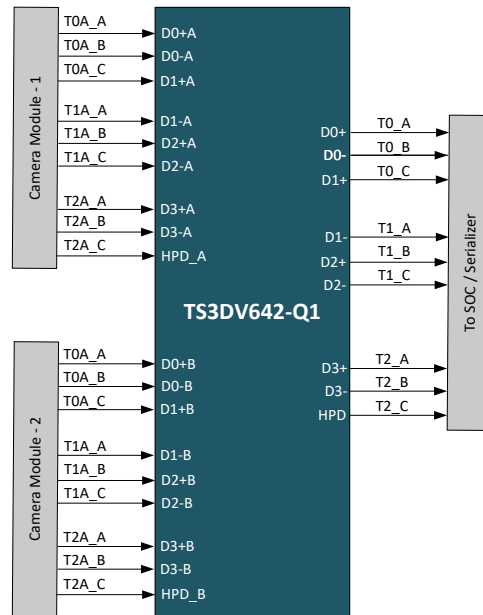Product Folder Links: *TS3DV642-Q1*

9.2.3.3 Mipi CPHY based CSI-2 switching

Figure 9-4. Mipi CPHY based CSI-2 switching
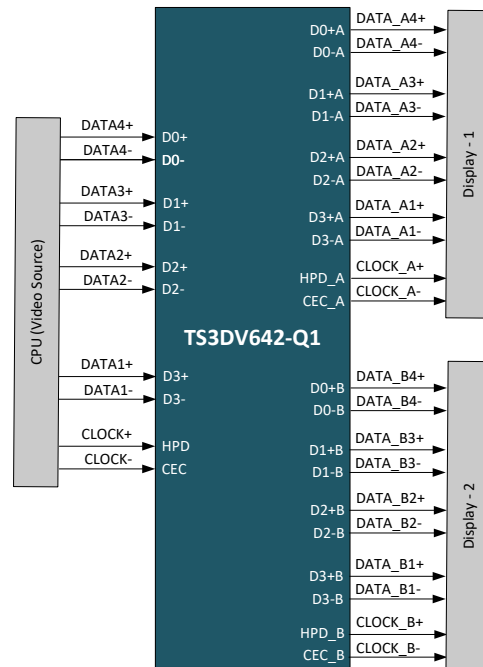
9.2.3.4 Mipi DPHY based DSI switching

Figure 9-5. Mipi DPHY based DSI2 switching

Product Folder Links: *TS3DV642-Q1*

ADVANCE INFORMATION

10 Power Supply Recommendations

V_{CC} should be in the range of 3.0 V to 3.6 V. Voltage levels above those listed in the Absolute Ratings table should not be used. Decoupling capacitors may be used to reduce noise and improve power supply integrity. There are no power sequence requirements for the TS3DV642-Q1.

ADVANCE INFORMATION

11 Layout

11.1 Layout Guidelines

To ensure reliability of the device, the following commonly used printed-circuit board layout guidelines are recommended:

- Decoupling capacitors should be used between power supply pin and ground pin to ensure low impedance to reduce noise To achieve a low impedance over a wide frequency range use capacitors with a high self-resonance frequency.
- ESD and EMI protection devices (if used) should be placed as close as possible to the connector.
- Short trace lengths should be used to avoid excessive loading.
- To minimize the effects of crosstalk on adjacent traces, keep the traces at least two times the trace width apart.
- Separate high-speed signals from low-speed signals and digital from analog signals
- Avoid right-angle bends in a trace and try to route them at least with two 45° corners.
- The high-speed differential signal traces should be routed parallel to each other as much as possible. The traces are recommended to be symmetrical.
- A solid ground plane should be placed next to the high-speed signal layer. This also provides an excellent low-inductance path for the return current flow.

ADVANCE INFORMATION

Product Folder Links: *TS3DV642-Q1*

11.2 Layout Example

TS3DV642-Q1 application with a single controller interfacing with two HDMI connectors.
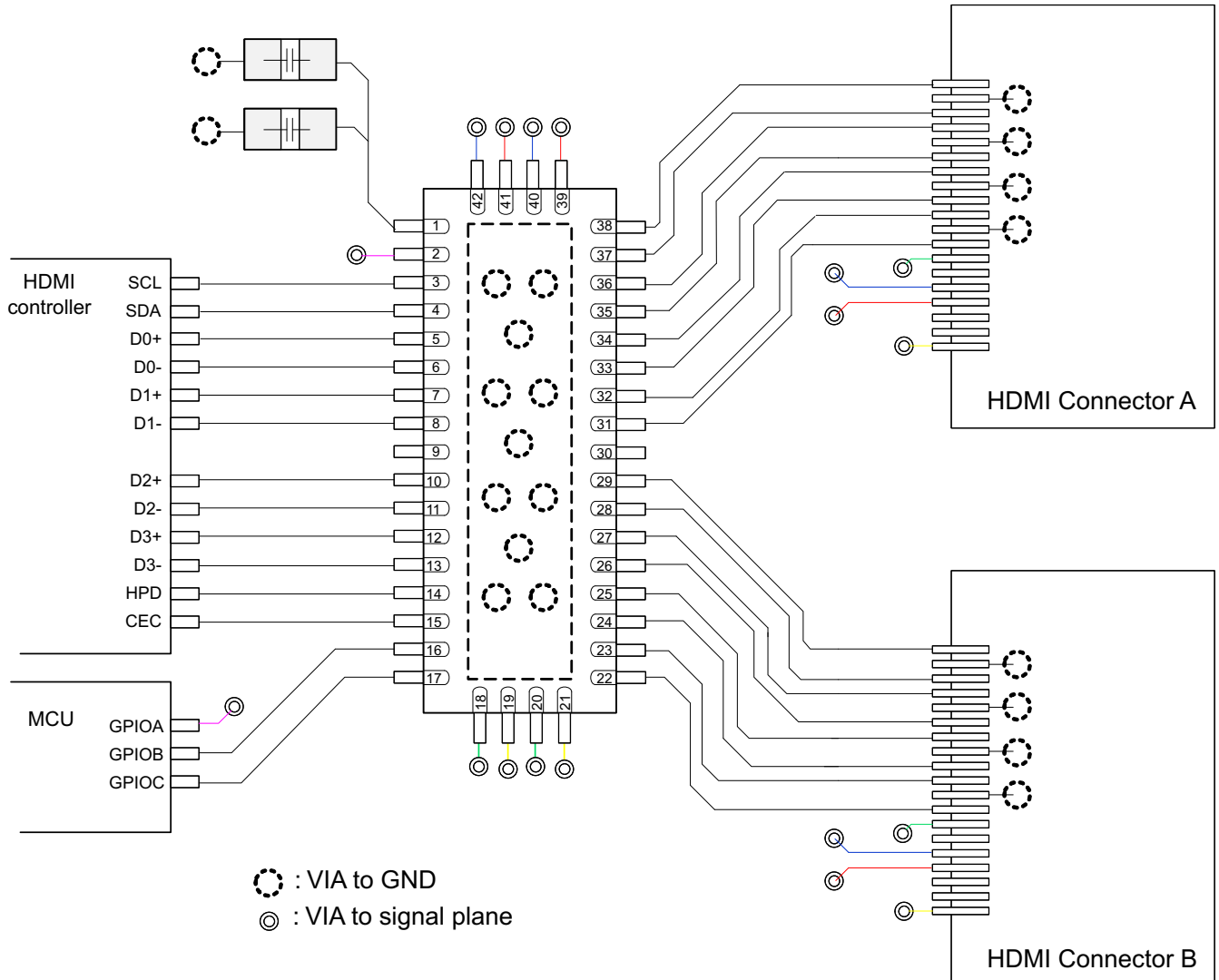

Figure 11-1. Layout Example

ADVANCE INFORMATION

ADVANCE INFORMATION

12 Device and Documentation Support

12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.2 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

12.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.
All trademarks are the property of their respective owners.

12.4 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.5 Glossary

TI Glossary   This glossary lists and explains terms, acronyms, and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TS3DV642RUARQ1	PREVIEW	WQFN	RUA	42	3000	RoHS (In work) & Non-Green	Call TI	Call TI	-40 to 105		
TS3DV642RUATQ1	PREVIEW	WQFN	RUA	42	250	RoHS (In work) & Non-Green	Call TI	Call TI	-40 to 105		
XTS3DV642RUAQ1	ACTIVE	WQFN	RUA	42	3000	RoHS (In work) & Non-Green	Call TI	Call TI	-40 to 105		Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.
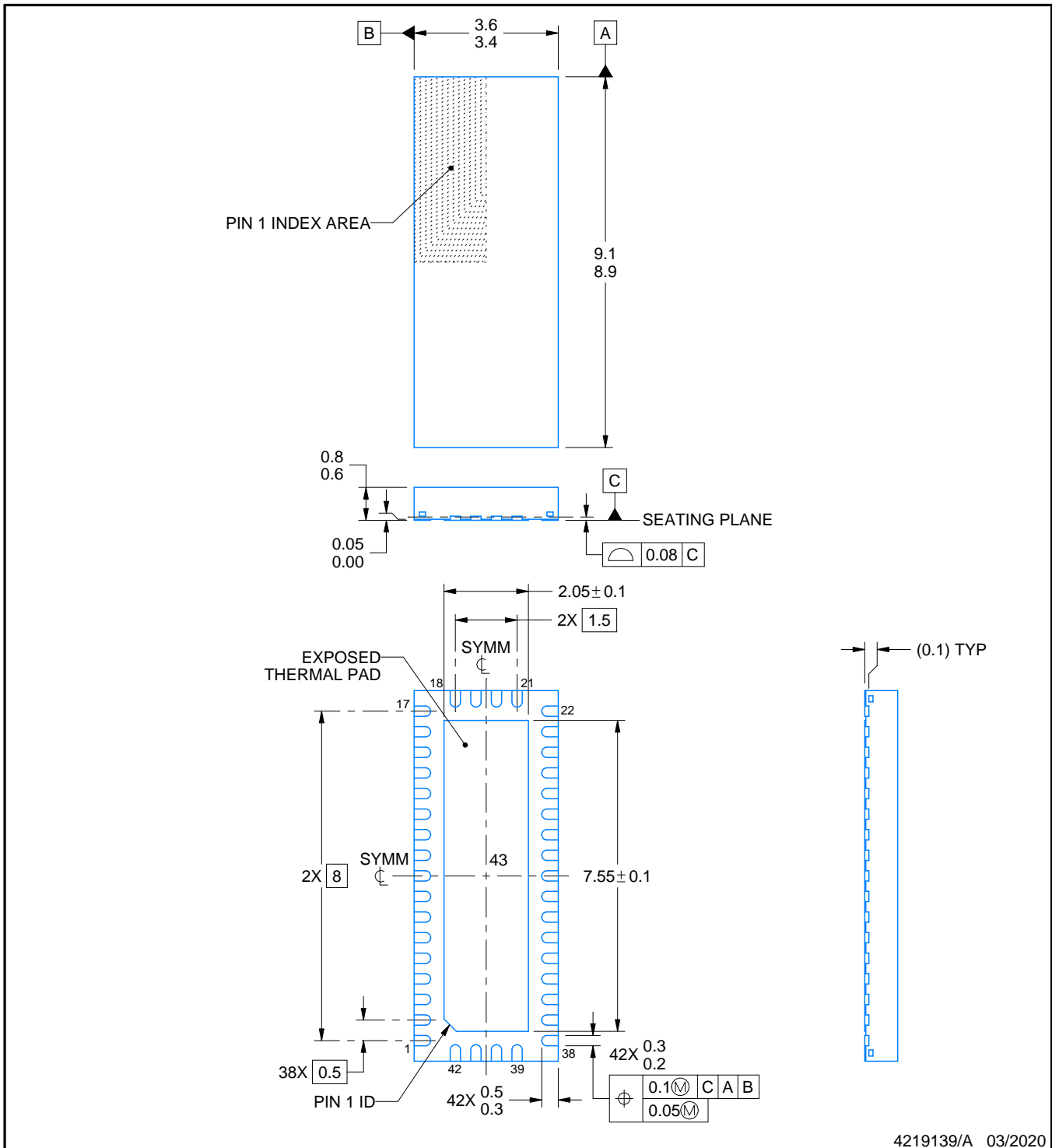
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF TS3DV642-Q1 :

● Catalog: TS3DV642

NOTE: Qualified Version Definitions:
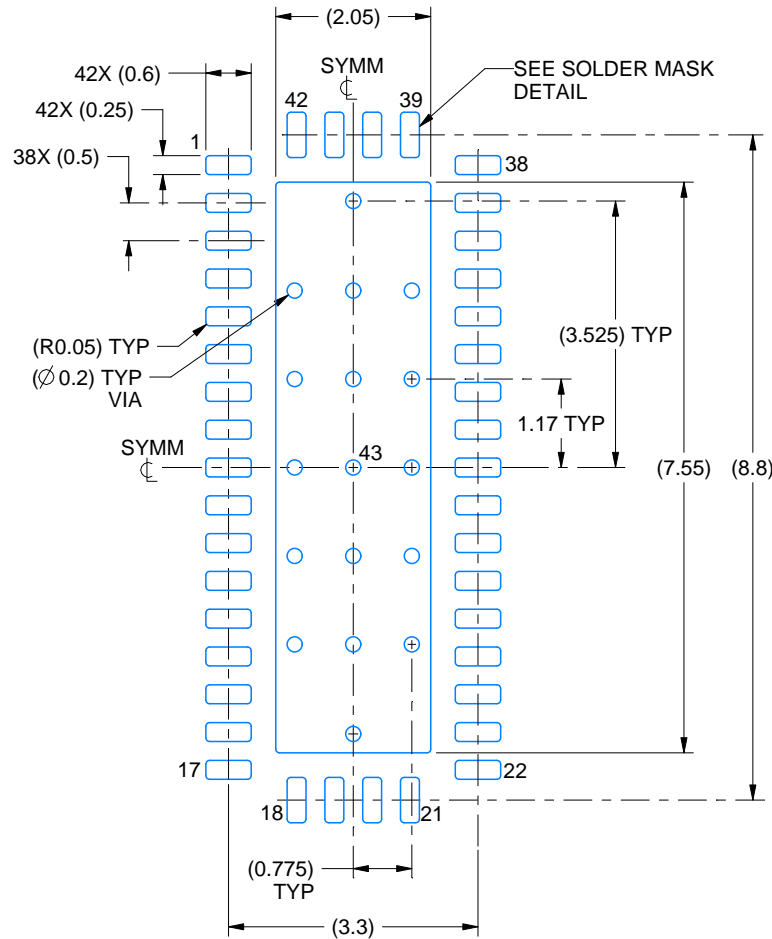
     ● Catalog - TI's standard catalog product

B | 3.6 / 3.4 | A

PIN 1 INDEX AREA

9.1 / 8.9

0.8 / 0.6

C

SEATING PLANE

0.05 / 0.00

$\boxed{\square \; 0.08 \; C}$

2.05 ± 0.1

2X $\boxed{1.5}$

SYMM ℄

EXPOSED THERMAL PAD

18   21

17   22

SYMM ℄

43

2X $\boxed{8}$

7.55 ± 0.1

(0.1) TYP

2X $\boxed{8}$

1

38X $\boxed{0.5}$

42   39

PIN 1 ID

42X $\boxed{0.5 / 0.3}$

38

42X $\boxed{0.3 / 0.2}$

$\boxed{\oplus \; \boxed{0.1 \text{M}} \; C \; A \; B}$
$\boxed{0.05 \text{M}}$

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NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

42X (0.6)

42X (0.25)

38X (0.5)

1

SYMM

(2.05)

42   39

SEE SOLDER MASK
DETAIL

38

(R0.05) TYP

(⌀ 0.2) TYP
VIA

SYMM

43

(3.525) TYP

1.17 TYP

(7.55)   (8.8)

17

18   21

22

(0.775)
TYP

(3.3)

LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X

0.05 MAX
ALL AROUND

METAL EDGE

EXPOSED
METAL

SOLDER MASK
OPENING

NON SOLDER MASK
DEFINED
(PREFERRED)

0.05 MIN
ALL AROUND

METAL UNDER
SOLDER MASK

EXPOSED
METAL

SOLDER MASK
OPENING

SOLDER MASK DEFINED

SOLDER MASK DETAILS
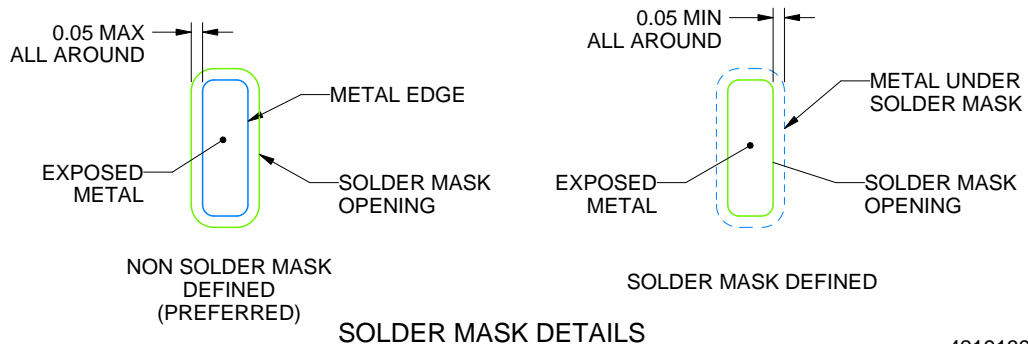
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NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature
   number SLUA271 (www.ti.com/lit/slua271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown
   on this view. It is recommended that vias under paste be filled, plugged or tented.

RUA0042A

42X (0.6)

42X (0.25)

38X (0.5)

(0.56) TYP

42

39

1

38

(R0.05) TYP

SYMM

43

(0.585) TYP

(8.8)

12X (0.97)

17

22

18

21

12X (0.92)

SYMM

(3.3)
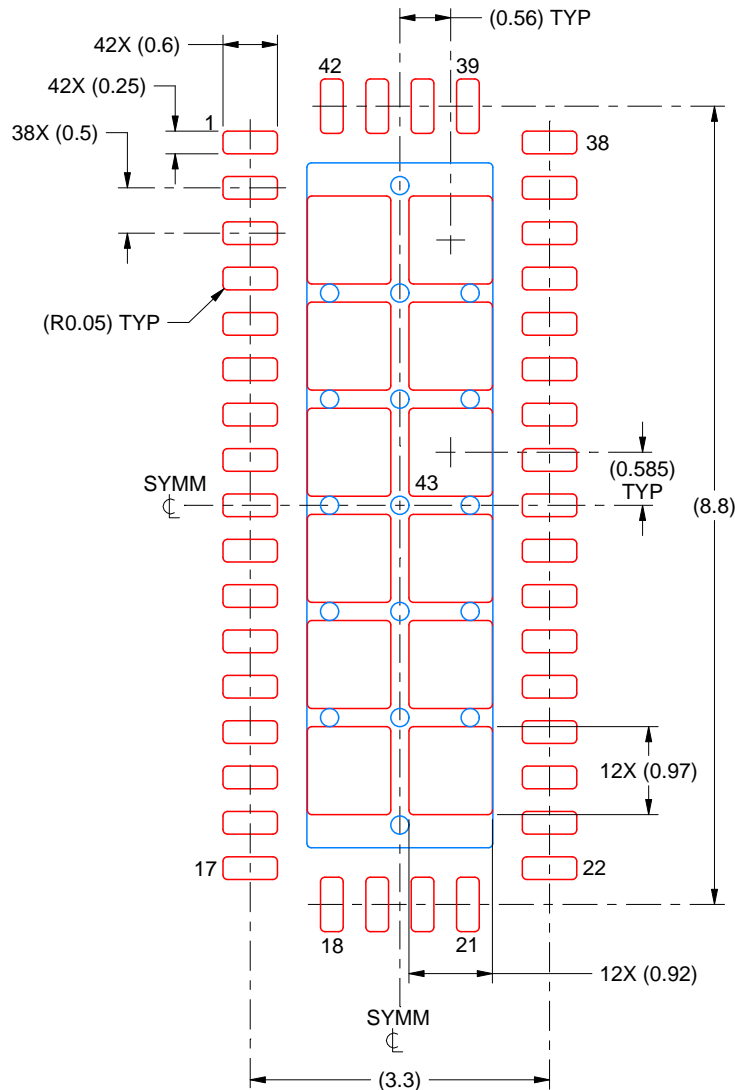
SOLDER PASTE EXAMPLE
BASED ON 0.125 MM THICK STENCIL
SCALE: 12X

EXPOSED PAD 43
69% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE

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NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate
   design recommendations.

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